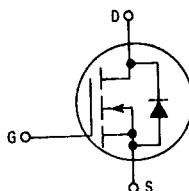


MOTOROLA
SEMICONDUCTOR
TECHNICAL DATA
Advance Information
Power Field Effect Transistor
**N-Channel Enhancement-Mode
Silicon Gate TMOS**

... designed for high voltage, high speed power switching applications such as switching regulators, converters, solenoids, relay drivers, inverters, choppers, audio amplifiers, and high energy pulse circuits.

- Silicon Gate for Fast Switching Speeds
- Low Drive Current Required
- Easy Paralleling
- No Second Breakdown
- Excellent Temperature Stability


2N6784
**N-CHANNEL
TMOS POWER FET**
 $r_{DS(on)} = 1.5 \text{ OHMS}$
200 VOLTS

CASE 79-05
MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Drain-Source Voltage	V_{DS}	200	Vdc
Drain-Gate Voltage ($R_{GS} = 1 \text{ m}\Omega$)	V_{DGR}	200	Vdc
Gate-Source Voltage	V_{GS}	± 20	Vdc
Drain Current Continuous	I_D	2.25	Adc
Pulsed	I_{DM}	9	
Total Power Dissipation @ $T_C = 25^\circ\text{C}$ Derate above 25°C	P_D	15 0.12	Watts W/ $^\circ\text{C}$
Operating and Storage Temperature Range	T_J, T_{stg}	-55 to 150	$^\circ\text{C}$

THERMAL CHARACTERISTICS

Thermal Resistance — Junction to Case	$R_{\theta JC}$	8.33	$^\circ\text{C/W}$
— Junction to Ambient	$R_{\theta JA}$	175	
Maximum Lead Temperature 1.6 mm from Case for 10 seconds	T_L	300	$^\circ\text{C}$

ELECTRICAL CHARACTERISTICS ($T_C = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Min	Max	Unit
Drain-Source Breakdown Voltage ($V_{GS} = 0, I_D = 0.25 \text{ mA}$)	$V_{(BR)DSS}$	200	—	Vdc
Zero Gate Voltage Drain Current ($V_{DS} = \text{Rated } V_{DSS}, V_{GS} = 0$) ($V_{DS} = 0.8 \text{ Rated } V_{DSS}, V_{GS} = 0, T_J = 125^\circ\text{C}$)	I_{DSS}	—	250 1000	μAdc

(continued)

This document contains information on a new product. Specifications and information herein are subject to change without notice.

MOTOROLA TMOS POWER MOSFET DATA

ELECTRICAL CHARACTERISTICS — continued ($T_C = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Min	Max	Unit
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OFF CHARACTERISTICS

Gate-Body Leakage Current, Forward ($V_{GS} = 20\text{ Vdc}$, $V_{DS} = 0$)	I_{GSSF}	—	100	nAdc
Gate-Body Leakage Current, Reverse ($V_{GS} = -20\text{ Vdc}$, $V_{DS} = 0$)	I_{GSSR}	—	-100	nAdc

ON CHARACTERISTICS*

Gate Threshold Voltage ($V_{DS} = V_{GS}$, $I_D = 0.5\text{ mA}$)	$V_{GS(th)}$	2	4	Vdc
Static Drain-Source On-Resistance ($V_{GS} = 10\text{ Vdc}$, $I_D = 1.5\text{ Adc}$) $T_A = 25^\circ\text{C}$ $T_A = 125^\circ\text{C}$	$r_{DS(on)}$	— —	1.5 2.81	Ohms
Drain-Source On-Voltage ($V_{GS} = 10\text{ V}$) ($I_D = 2.25\text{ Adc}$)	$V_{DS(on)}$	—	3.37	Vdc
Forward Transconductance ($V_{DS} = 5\text{ V}$, $I_D = 1.5\text{ Adc}$)	g_{FS}	0.9	2.7	mhos

DYNAMIC CHARACTERISTICS

Input Capacitance	$(V_{DS} = 25\text{ V}$, $V_{GS} = 0$, $f = 1\text{ MHz})$	C_{iss}	60	200	pF
Output Capacitance		C_{oss}	20	80	
Reverse Transfer Capacitance		C_{rss}	5	25	

SWITCHING CHARACTERISTICS*

Turn-On Delay Time	$(V_{DD} \approx 75\text{ V}$, $I_D = 1.5\text{ A}$, $R_{gen} = 50\text{ ohms})$	$t_{d(on)}$	—	15	ns
Rise Time		t_r	—	20	
Turn-Off Delay Time		$t_{d(off)}$	—	30	
Fall Time		t_f	—	20	

SOURCE DRAIN DIODE CHARACTERISTICS*

Diode Forward Voltage	$(I_S = \text{Rated } I_{D(on)}$ $V_{GS} = 0)$	V_{SD}	0.7	1.5	Vdc
Forward Turn-On Time		t_{on}	—	Negligible	ns
Reverse Recovery Time		t_{rr}	290 (Typ)	—	ns

*Pulse Test Pulse Width $\leq 300\text{ }\mu\text{s}$, Duty Cycle $\leq 2\%$.

OUTLINE DIMENSIONS

